



Structural Health Monitoring & Nondestructive Testing 2020

Guest Editors:

Prof. Xavier Maldague

maldagx@gel.ulaval.ca

Prof. Valérie Kaftandjian-Doudet

valerie.kaftandjian@insa-lyon.fr

Prof. Ahmad Osman

ahmad.osman@
izfp.fraunhofer.de

Dr. Bastien Chapuis

bastien.chapuis@cea.fr

Prof. dr. ir. Gunther Steenackers

gunther.steenackers@
uantwerpen.be

Dr. Hai Zhang

hzhang@mie.utoronto.ca

Deadline for manuscript
submissions:

30 November 2020

Message from the Guest Editors

Dear Colleagues,

The aim of the International Symposium on Structural Health Monitoring and Nondestructive Testing is to provide an overview of the latest breakthroughs in SHM and NDT and their interactions with various industrial sectors. SHM-NDT 2020 will be held in **Québec City, Canada on 14-15 May 2020**. This joint Special Issue is expected to select excellent papers **in** and **out** SHM-NDT 2020 in the following topics, but not limited to:

- 1) Structural health monitoring;
- 2) NDT sensors, detectors and sources: ultrasound, acoustical emission, X-ray, thermography, eddy currents, EMAT etc;
- 3) Modeling and simulation;
- 4) Reliability, probability of detection;
- 5) Sensor data fusion;
- 6) Reconstruction techniques;
- 7) Defect detection & localization methods;
- 8) Signal and image processing.

All papers must be submitted by the deadline **15 June 2020**. All selected and peer-reviewed papers will be organized as in a dedicated book with an ISBN number.

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